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AMENDMENTS TO THE SPECIFICATION

Please replace the specification with the following amended specification:

AN X-RAY DIFFRACTION (XRD) MEANS FOR IDENTIFYING THE CONTENT IN A VOLUME OF INTEREST AND A METHOD THEREOF

FIELD OF THE INVENTION

The present invention generally relates to an XRD means and for identifying the content in a volume of interest and to a method thereof.

BACKGROUND OF THE INVENTION

Crystalline materials can be identified by their x-ray diffraction (XRD) pattern, which is unique to each material and can serve as its 'finger[[]]print'. Among the materials that present security hazards of security's sake interest are explosives, illegal drugs and spores (e.g. Anthrax spores). The patent suggests a remote detection method to identify suspected materials according to their XRD pattern. The suspected material in a Volume Of of Interest (VOI)[[,]] should be may be recognized by lower stage detection systems, such as: X-ray imaging system, Average density identification by multiple energy X-ray system, NMR (MRI), NQR, IR imaging, Millimetric Waves millimeter wave imaging, Terra Hertz THz imaging, etc.

If monochromatic X-rays impinge upon a polycrystalline sample with randomly oriented crystallites, then some of the crystallites fulfill Bragg's law with respect to the x-ray beam. Thus, all reflections belonging to a particular lattice plane are distributed upon the mantle of a circular cone, of which the x-ray beam is the axis and the aperture angle is 40. An x-ray sensitive film or an X-ray detector placed perpendicularly to the x-ray beam will thus record concentric circles-as a diffraction image comprising a series of a series of concentric circles. The Bragg[['s]] angle is given by equation (1):

$$\theta = \frac{1}{2} \arctan \frac{D}{2x} \tag{1}$$

wherein \underline{D} is the diameter of a diffraction ring is \underline{D} , and x is the distance between the sample and the film.

A variety of X-ray detectors were have been presented in the art. Digital Radiography X-ray recording eomprised of comprises the steps of capturing X-ray photons and converting the recorded signal to an electrical signal. These systems are intrinsically pixelated pixelated to form either a pixilated pixelated array or a continues continuous array with a moving "pixel[[]]ated-bridge" ("pixilated pixelated-bridge" means a one-dimensional or very narrow two-dimensional scanning pixel array). The detectors may be schematically divided into two main groups, namely direct and indirect detectors. Direct detectors use a plurality of photoconducting materials such as Silicon, Germanium, Selenium, silicon, germanium, selenium, CdTe, CdZnTe, PbI2 or HgI2, and are adapted for directly converting x-ray energy into electric charge utilizing TFT (Thin Film Transistor), CMOS (Complementary Metal-Oxide Semiconductor) technology or any other type of substrate whether eontinues continuous or pixe[[1]]lated array. This charge can be then captured, stored and recorded. Indirect detectors use a plurality of scintillator materials such as NaI, CsI or Gd2O2S, to convert the x-ray energy into visible or UV light, which must be optically coupled to a photosensitive device. e.g. a photo-diode[[s]] array or charge coupled devise device (CCD). This photo sensor then converts the light into electric charge, which can be captured, stored and recorded.

Indirect conversion is a two_step[[s]] process wherein X-rays are first converted by a means of a scintillator or phosphor material to optical lower energy, e.g. visible light, photons that are being then collected and converted into an electric charge. Commercially available products of GE Medical Equipment Inc. comprising an amorphous silicon flat panel with a Cesium Iodide scintillator is an example for of such a technique.

Direct conversion is <u>a</u> single conversion step process. At least three types are known in the art: TFT, CMOS and Continuous plates. The TFT is coated <u>by with</u> a photoconductor, wherein the detector uses [[a]] direct conversion of x-ray energy into electrical signals. No light-emitting materials, intermediate steps and/or additional processes are required to capture and convert the incident x-ray energy. The commercially available products of Hologic Inc. are <u>an</u> example <u>for of</u> this type, wherein <u>an Amorphous Selenium amorphous selenium</u> photoconductor is used. <u>Continuous Continuous</u> plates are scanned by means of a moving

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pixellated-bridge. A selenium-based sensor is used to convert incident X-rays into an electric

charge image. The charge image is transformed into a digital image using this bridge, which

eliminates the <u>need for</u> costly and often-problematic active matrix arrays. The commercially available products of Edge Medical Devices Ltd. and its Scanned Matrix Array Readout

Technology (SMART) is utilizing uses this technology[[,]].

US Pat. No. Application 2001/0033636 to Hartick et al. (now abandoned) discloses a method

and apparatus for determining a material of a detected item and deals with a specific method of defining a VOI by means of calculating the average density of the detected volume and a

correlation between the VOI and the XRD shots.

US Pat. No. 2003/0169843 6,839,406 to Ries et al. presents a method and an apparatus for

detecting unacceptable items in objects, such as in luggage, wherein a detector apparatus,

functioning as a second detector stage is divided into a lower <u>level</u> testing stage and a higher level testing stage. This invention deals with a novel and vet specific energy dispersion

method of XRD

BRIEF DESCRIPTION OF THE INVENTION

In order to understand the invention and to see how it may be implemented in practice, a plurality of embodiments will now be described, by way of non-limiting example only, with

reference to the accompanying drawings, in which

figure 1 schematically presents a plurality of a typical powder X-ray diffraction ring[[s]]

pattern[[.]], also known as \underline{a} "Debye-Scherrer" pattern, in a view comprising only

the middle portion of the ring; a diffraction characterized by a set of three 40s is presented (right hand view); a back-diffraction characterized by a set of three

360°-4θ is also presented (left hand view):

figure 2 schematically presents a remote XRD means for identifying the content of the

volume of interest (VOI) according to one embodiment of the present invention;

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figure 3 schematically presents a remote XRD means for identifying the content of the VOI

according to yet another embodiment of the present invention;

figure 4 schematically presents a remote XRD means for identifying the content of the VOI

according to yet another embodiment of the present invention;

figure 5 schematically presents a remote XRD means for identifying the content of the VOI

according to yet another embodiment of the present invention:

figure 6 schematically presents a remote back-scattered XRD means for identifying the

materials located in the VOI according to yet another embodiment of the present

invention:

figure 7 schematically presents a method for identifying materials located in the VOI

according to one embodiment of the present invention;

figure 8 schematically presents a method for identifying materials located in the VOI

according to yet another embodiment of the present invention;

figure 9 schematically presents a method for identifying materials located in the VOI

according to yet another embodiment of the present invention; and,

figure 10 sehematically presents a method for identifying materials located in the VOI

according to yet another embodiment of the present invention; and

figure 11 schematically presents a Cell-X detector according to yet another embodiment of

the present invention.

SUMMARY OF THE INVENTION

It is thus one object of the present invention to provide a useful remote XRD means for

identifying the materials located in a volume of interest (VOI). Said means are comprised of comprise a plurality of N X-ray sources targeted towards said VOI adapted to emit a well

characterized X-ray beam (i.e., shot) towards the target[[;]], wherein N is an integer number

higher greater than 1, preferably from 1 to 20; a plurality of M two dimensional (2D) X-ray detectors adapted to receive diffracted X-rays so an image comprising at least a portion of the obtained XRD patterns is obtained; wherein M is an integer number higher greater than 1, preferably from 1 to 100; a processor adapted to measure said patterns; a database comprising records of patterns' parameters characterizing predetermined material; said database comprising records of materials that a notification should be provided when identified; and an alerting means adapted to alert the operator when wherein the identified material in the VOI is one of said predetermined groups. This means is potentially adapted to identify sampled moving VOIs in a non-intruding non-intrusive manner. It may further comprised—of suitable means to sample the material in the VOI so that the operator is notified of the presence of the material-is-notified; and means to surveillance track or follow up said VOI before identifying its nature. Those remote XRD means are preferably adapted to alert either online or offline, to alert to a predetermined remote location, to be in communication with effective means adapted to isolate or immobilize said VOI transport until subsequent notification or any combination thereof.

It is acknowledged in this respect that one X-ray source may be providing for a plurality of shots. Hence a single 2D X-ray detector may be synchronized to detect each shot in a way that it is centered and relocated at a perpendicular position to the beam or a plurality of 2D X-ray detectors, which are synchronized, with the beam of the shot.

It is another object of the present invention to provide a method for acquiring an XRD image of a material inside a VOI. This method is eemprised comprises the steps of receiving VOI coordinates from a lower stage system; irradiating the material in the VOI; acquiring of Debye-Scherrer_XRD patterns of the material in the VOI; extracting of VOI-s Debye-Scherrer_XRD patterns; converting the ring said_XRD patterns (e.g. rings) of said material VOI to standard powder X-ray diffraction spectrum spectra; scarching and/or matching records in a database for material identification; and then, alerting in case said material is in matching matches a predetermined record. It is well in the scope of the present invention wherein this method is provided by the means as defined in any of the above; wherein back[[]]]scattering is obtained and/or wherein energy information is collected in addition to the imaging calculations via the use of a Cell-X detector or Gamma Camera.

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DETAILED DESCRIPTION OF THE INVENTION

The following description is provided, alongside all chapters of the present invention, so as to

enable any person skilled in the art to make use of said invention and sets forth the best modes contemplated by the inventor of carrying out this invention. Various modifications.

however, will remain apparent to those skilled in the art, since the generic principles of the

present invention have been defined specifically to provide a remote process for identifying

hazardous materials such as explosives in a VOI by means of an XRD based system.

It is the object of the present invention to provide a cost effective, secure, reliable and rapid

system for enabling [[a]] remote detection of hazardous materials and thus to provide for

passengers and/or their carry-on luggage to walk in a reasonably wide corridor while being

examined by the system.

The term 'materials in a volume of interest' is related to hazardous materials, such as

explosives, flammable[[,]] or toxic materials, chemical and biological warfare substances in

either gas, liquid or solid states, drugs and narcotics, radioactive agents etc., and to metallic materials, such as iron, gold, platinum and any other valuable crystalline materials (e.g.

ceramics), which are suitable for XRD analysis. The VOI is hence denoted according to the

present invention to as any 3D eapacity volume to be analyzed.

According to one embodiment of the present invention, those materials are related to any of

the hereto-defined hazardous or crystalline materials, being transferred on carried by a

passenger and/or in his carry-on luggage, especially in airports and similar locations.

According to one specific embodiment of the present invention, said material is selected from any explosive materials. According to yet another specific embodiment of the present

invention, said material is selected from any chemical or biological warfare agents.

It is in the scope of the present invention wherein the material in the VOI is located. analyzed, identified, and marked by any means, such as X-ray Imaging system, average

density identification by Multiple Energy X-ray system, NMR (MRI), NOR, Laser

Spectroscopy, IR imaging, Millimeteric Waves millimeter wave imaging, Terra-Hertz THz

imaging, etc.) at as a first step, and then said material is further analyzed by the remote XRD

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means as defined and described in the present invention. The surveillance of and follow-up after the VOI identified at the first step may be provided by various video techniques or other means adapted for online image processing, whereat said VOI is transferred along a predetermined course, on a conveyor belt etc. and especially whereat said VOI is transferred along a non-predetermined course (e.g., incidental movement of a passenger with his carry-on luggage in a corridor).

It is in the scope of the present invention wherein said material in the VOI is a subject of imaging by a system comprising a combination of a plurality of X-ray sources and a plurality of X-ray[[s]] detectors. Additionally or alternatively, said VOI is a subject of a sequence of subsequent imaging steps ('shots') taken by the aforementioned complex system, so [[a]] that reliable and rapid analyzes analyses are provided.

The term 'XRD' is referring to refers to any method for determining the nature of a sample by calculating its diffraction pattern in either scattered or back-scattered techniques. More[[]] over, the term XRD is also referring also refers to any scattering or back-scattering system and/or to an incorporated system comprising XRD or back-scattered XRD with analyzing means adapted for energy or energetic detection, such as a Detector Array system which is providing provides energy characteristics of the X-rays scattered by the material in the VOI, or a combination of the detectors array which is providing provides [[a]] simultaneous energy and image characteristics of the X-rays scattered by the material in the VOI.

The system basically consists of <u>a</u> collimated X-ray source synchronized with <u>a</u> 2D detector array. The X-ray source provides a narrow collimated beam that passes through the VOI. The X-rays are diffracted from the sampled material (and its neighboring materials which are in the X-ray beam path). The diffracted pattern is recorded by the two-dimensional array. Image processing is applied in order to define the number, diameter, intensity and broadening of the XRD patterns (e.g. the Debye-Scherrer rings). The XRD patterns are converted to standard powder XRD patterns and existing or proprietary search/match utilities or software (such as the commercially available Rietveld based software) can be used to identify the material.

Reference is made now to figure 1 presenting a schematic Reference is made now made to figure 1, schematically presenting a plurality of Debye-Scherrer rings in a narrowed view, which eomprised of comprises the central portion of the ring. This diffraction is characterized

by an exit hole (1) and a set of three 40s (See (2) for example). Adjacent to the left side of the presentation, a back-diffraction is provided, wherein the insert hole (3) is surrounded by a set of three 360° -40s (See (4) for example).

Reference is made now made to figure 2, schematically presenting one embodiment of the present invention wherein a plurality of XRD patterns (1-3) are located at various spatial positions are acquired by one X-ray source and one mechanically synchronized 2D detector. Here, one X-ray source (e.g., an X-ray generator) is synchronized with a detecting plate in a way that the beam passes through the VOI. The X-ray generator is being moved between pluralities of predetermined locations, and the location of the detecting plate is synchronized with it. The process-repeats itself for the improvement of is repeated in order to improve the detection rate. The x-ray source (21) is producing produces a sufficient amount of X-rays, which are potentially processed by a means of a collimator (22) before said processed X-rays (23) reach the VOI (24) accommodated in a container (25). According to the present invention, such an X-ray producing means (20) is comprised of comprises an X-ray source (21), a collimator (22) or any other means adapted to process the produced X-rays produced in order to provided for an effective X-ray beam (e.g. a focusing element). The diffracted Xrays are being obtained by a means of at least one two 2-dimensional detector (26) so that a measurable plurality of XRD patterns (27) is obtained. Locations (1-3) are the positions of the x-ray source wherein (1', 2', 3') are the relative positions of the aforementioned 2D detector (26).

Reference is made now made to figure 3, schematically presenting a moving VOI, e.g., an object being transferred or a passenger walking with his carry-on-luggage, whereat a plurality of X-ray beams are emitted in the manner the beams are synchronized with the X-ray detectors. Fig. 3 is thus schematically presenting presents a novel non-intruding non-intrusive system (30) according to yet another embodiment of the present invention, which is especially adapted for obtaining multiple X-ray diffractions. This system (30) is especially useful for analyzing moving VOIs, and is-comprised of comprises an X-ray source, such as source (31), which is adapted to emit X-rays over a VOI (33) being moved along a corridor (32) in the direction (D). The X-ray source (31) is emitting a beam (A) over the sample located in site 34, so the diffraction is recorded by the 2D detector 37A; and a plurality of other beams directed to another one or more predetermined angles and directions,

synchronized with the new location of the VOI at each particular time. For example, source (31) is-directing directs its beams in the a manner such that the VOI is sampled in along its way travel (D) on eenveyer conveyor (32), namely at locations 35 and 36, by beams B and C, so that diffractions B' and C' are provided on 2D detectors 37B and 37C, respectively.

Reference is made now made to figure 4, schematically presenting another embodiment of the present invention, wherein the system is adapted to obtain[[ed]] a plurality of XRD pattern images on one 2D detector from a plurality of x-ray beams. Fig. 4 hence illustrates a system wherein a plurality of shots are taken by either by a plurality of X-ray generators or one moving X-ray generator; wherein all the XRD patterns are detected on one big detecting plate. Each shot is being taken in a way manner such that the beam passes through the VOI. Here for example, three X-ray sources are provided, 41A-C. Each source is comprised of comprises an X-ray source and a collimator or any equivalent device (42A-C). Hence, three X-ray beams (43A-C) are directed towards the VOI (44) located in a container (45). Each beam is targeting targets a predetermined portion position at the 2D detector (46), in the manner such that three XRD patterns (47A-C, respectively) are obtained.

Reference is made now made to figure 5, schematically presenting another embodiment of the present invention, adapted to obtain [[a]] multiple XRD patterns simultaneously using frem a plurality of X-ray beams and a plurality of 2D detectors. Here, a plurality of X-ray sources (e.g., X-ray generators) are targeted towards an identical number of X-ray detectors (e.g., detecting plates) while each of them is synchronized to penetrate the VOI. It is acknowledged in this respect that any number of X-ray[[s]] sources and detectors are applicable at in a variety of combinations, and different source[[s]] to detector[[s]] ratios are possible. Here, three X-ray sources (51A-C) are hereto presented. Each source is-comprised of comprises an X-ray source and a collimator or any equivalent device (52A-C). Hence, three X-ray beams (53A-C) are directed towards the VOI (54) accommodated in a container (55). Each XRD provided by said three beams is-targeting targets a predetermined 2D detector (56A-C).

Reference is made now <u>made</u> to figure 6, schematically presenting aecording to yet another embodiment of the present invention, a system (60) that is adapted to obtain at least one back-scattered XRD. The X-ray source (61) is generating generates at least one beam (63) targeted towards the sample in the VOI (64) in a container (65) in the manner such that a

back-scattered beam (63) is recorded on a 2D detector (66). It is further acknowledged that system (60) may be used simultaneously with one or more other back-scattering systems and/or with one or more systems as defined and described above, such as aforementioned systems 20, 30, 50 etc.

It is the object of the present invention to provide a useful and remote method for identifying the content of a VOI. It is thus according to yet another embodiment of the present invention wherein the aforementioned process is comprised of comprises the general following following general steps:

- i. receiving of VOI coordinates from lower stage system;
- ii. irradiating the material in said VOI by one or a plurality of collimated X-ray beam(s):
- iii. acquiring of XRD pattern results from each impinging X-ray beam;
- iv. extracting of the XRD pattern of the material;
- converting the ring XRD pattern of the material to <u>a</u> standard powder X-ray diffraction spectrum (Intensity against two Theta 20);
- vi. searching and/or matching <u>a</u> data[[]]base for material identification (e.g. according to the Rietveld method); and then,
- vii. alerting (Y/N).

Reference is made now made to figure 7 presenting a schematic flow chart of another embodiment of the present invention; wherein in step (71) an information concerning the VOI, i.e., an X, Y & Z information, is obtained by a prior step of allocating the VOI (not shown here). The collimated X-ray beam is targeted towards the center of the VOI.

A set of images of an XRD pattern or patterns (i.e., rings) of the VOI obtained by 2D detector array is acquired at step (72). Now at step (73), a plurality of calculations on each image is provided to complete missing or unclear arcs in the ring shape. Step (74) is-comprised of comprises the application of subtraction calculations or any other image processing calculations adapted to find the common XRD pattern of said VOI as it appears in the set of all images. At the following step (75), the center of broadening of the ring line is determined, especially for thick or (spreaded diffuse) blurred lines. In some cases, the entire ring pattern may not revealed, but rather a part of it. It is possible to find the required data from a part of the ring only. Also, calculations on the average perimeter of the ring will allow higher reliability. Subsequently at step (76), the ring diameter is determined, in the manner that ring

intensity and ring broadening of the extracted VOI pattern is obtained. At step (77) the ring pattern is being converted to powder XRD spectrum. Then, at step (78), matching the obtained XRD pattern with known materials in database is provided, wherein at case of matching, the VOI is positively identified. It is acknowledged in this respect that when hazardous materials are identified, an effective inline or offline alert is provided (78A). If such [[a]] matching is not provided (78B), a general alert or a specific notification is provided, and the aforementioned process is repeated in the manner that a plurality of XRD images and/or other analytical characterizations are subsequently taken from different angles. In the case that after N states, wherein N is an integer number higher one greater than 1, the system has not absolutely identify identified the material as hazardous, but [[a]] the possibility for of the existence of such material dogs exist[[s]], than then a special alert will be given to the operator.

It is acknowledged in this respect that the term 'alarm' according to the present invention is referring refers to any notification given to either a remote site or to the operator located adjacent to the system. The alert is selected in a non-limiting manner from alarm, applicable especially wherein when hazardous materials are detected in the VOI; appearing all-clear notification, especially applicable wherein when non-hazardous materials are eemprised present in the detected VOI and/or wherein the VOI is analyzed to be non hazardous; and notification per se; applicable especially wherein the system is operated in a specific mode of recording the nature/composition of goods and/or materials passing throughout a predetermined path.

Reference is made now made to figure 8 presenting a schematic flow chart of another embodiment of the present invention; wherein in step (81) [[a]] VOI information, i.e., an X, Y & Z information is obtained by a prior step of allocating the VOI (not shown here). During the examinating examination, a sub-system tracks the VOI, and supplies its (changed) coordinates when required. The collimated X-ray beam is targeted towards the center of the VOI. A set of images of an XRD pattern or patterns (e.g., rings) of the VOI obtained by 2D detector array is acquired at step (82). Now at step (83), a plurality of calculations on each image is provided to complete missing or unclear arcs in the ring shape. Step (84) is emprised of comprises the application of subtraction calculation, adapted to find the common XRD pattern of said VOI as it appears in the set of all images. At the following step

(85), the center of the ring line is determined, especially for thick or spreaded diffuse lines. Subsequently at step (86), the ring diameter is determined, in the manner such that ring intensity and ring broadening of the extracted VOI pattern is obtained. At step (87) the ring pattern is being converted to a powder XRD spectrum. Then, at step (88), matching the obtained XRD pattern with known materials in the database is provided, wherein at in the case of matching, the material in the VOI is positively identified (hazardous material is identified) the and an alert is provided (88A). If such a matching is not provided, the aforementioned process is repeated (88B). In the this manner, that a plurality of XRD images or other analytical characterizations are subsequently taken from different angles regarding the moving target. The new VOI coordinates are supplied to the system from a tracking subsystem (89). In the case that after N states, wherein N is an integer number higher one greater than 1, the system has not absolutely identified the material a hazardous, but a possibility for the existence of such material does exist[[s]], than then a special alert will be given to the operator.

Reference is made now made to figure 9 presenting a schematic flow chart of yet another embodiment of the present invention; wherein in step (91) [[a]] VOI information, i.e., an X, Y & Z information is obtained by a prior step of allocating the VOI (not shown here). A plurality (e.g., three) of collimated X-ray beams are is targeted towards the center of the VOI, where each X-ray generator is located at a different location. A set of images of a complex XRD pattern or patterns (e.g., rings) of the material in the VOI obtained by 2D detector array is acquired at step (92). Now at step (93), a plurality of calculations on each pattern is provided to complete missing or unclear arcs in the ring shape. Step (94) is comprised of comprises the application of subtraction calculation, adapted to find the common XRD pattern of said VOI as it appears in the set of all images. At the following step (95), the center of the ring line is determined, especially for thick or spreaded diffuse lines. Subsequently at step (96), the ring diameter is determined, taking into account the ellipsoidal shape of some of the patterns, in the manner that ring intensity and ring broadening of the extracted material pattern is obtained. At step (97) the ring pattern is being converted to a powder XRD spectrum. Then, at step (98), matching the obtained XRD pattern with known materials in database is provided, wherein at in the case of matching, the material is positively identified (when a[n] hazardous material is identified, an the alert is provided) (98A). If such [a] matching is not provided, an alert is provided, and the aforementioned process is repeated

(98B) in the manner such that a plurality of images or any other analytical characterizations are subsequently taken using the different angles plurality of sources regarding the moving target. In the case that after N states, wherein N is an integer number higher one greater than 1, the system has not absolutely identify identified the material as hazardous, but a possibility for the existence of such material does exist[[s]], than a special alert will be given to the operator.

Reference is made now made to figure 10 presenting a novel multi-functional detector[[s]] array adapted for a flexible cellular-XRD technology (100), according to yet another embodiment of the present invention, denoted hereinafter in by the term 'Cell-X'. The technology is especially useful for [[a]] remote detection of explosive materials, and is based on incorporating combining XRD imaging with acquiring acquisition of energy information. The detector is comprised of comprises two general ingredients; imaging detectors (101), and an energy means (spectrometer detector) (102), much similar to those known in the art. Those These commercially available means are adapted for the detection of the XRD patterns (e.g., Debye-Scherrer rings) on a 2D pixel array detector. According to a more specific embodiment of the present invention, which is described in figure 10, each "unit cell" consists of a 2D array detector surrounded by a plurality of stripes of one-dimensional or a very narrow (very thin) two-dimensional array of detector elements having energy resolution able to resolve photon energies (i.e., perform spectroscopic measurements spectroscopy abilities), such as stripes of solid state single crystal detectors, stripes of scintillation detectors etc. The Cell-X is comprised of comprises small, medium, or large unit cells or any combination thereof. According to one embodiment of the present invention, the size of the Cell-X is approximately that of a human-being size (220 cm [[X]] × 80 cm), which is enabling XRD examinations of a passenger entering the gate[[s-]] area of an airport when walking with his carry on luggage. Cell-X is providing provides imaging information, while simultaneously is providing energy information, so XRD patterns are recognized as part of the imaging while energy information can be collected from each spectroscopy detector element (pixel) crossed by an XRD pattern.

The "flexibility" of the Cell-X is in its cell[[s]] sizes and ratio between the imaging arrays and the spectroscopy stripes (arrays). It may vary from very large imaging arrays surrounded by spectroscopy stripes, through small imaging arrays surrounded by verity of thickness

spectroscopy arrays of varying thicknesses, and up to a unit in which the size of each imaging array will be zero thus the actual spectroscopy array will be the whole array detector. This Cell-X array which is entirely structured of consisting entirely of a spectroscopy array may serve as a Gamma Camera, but for our remote detection needs it will work as follows: (i) the array has now a dual capability (imaging and spectroscopy) all over the array; (ii) the whole array will serve as an imaging array, and will work like any of the above mentioned imaging arrays; and (iii) the whole array will serve as a spectroscopy array. Certain pixels, which are part of the XRD patterns, will be analyzed for energy information, in order to speed up the recognition process. It should be noted that the number and the location of each pixel to be energetically analyzed may vary from a predetermined location of for each sampled pixel and the number of pixels and up to the case in which the number of pixels to be sampled and their locations coincide a coincidence number of pixels to be sampled and their locations coincide